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				APPLICANT Takeshi ONO, et al.						
(PTO-1449)				FILING DATE GROUP March 05, 2002 GROUP 2641						
			U	S. PATEN	r documents					
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025			JP 11-052984	02/26/1999	FUJITSU LTD			abstract		
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

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DLS	2000-203357	07/25/00	JAPAN (w/E	nglish Abstract)					
825	2000-193479	07/14/00	JAPAN (w/E	nglish Abstract)					
	OTHER	ART (Inch	uding Author.	Title, Date, Per	tinent P	ages, Etc.)			
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EXAMINER Donald L. Storm DATE CONSIDERED 3/4/25									